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Application/Control No.	Applicant(s)/Patent under Reexamination
09/902,752	BAUDOIN ET AL.
Examiner	Art Unit
Thien D. Tran	2616

SEARCHED				
Class	Subclass	Date	Examiner	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
See seard	ch printout	7/8/2996	π

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (USPGPUB, USPAT, USOCR, EPO, DERWENT) 370/322, 395.43, 468	7/8/2006	тт
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